

CD40181B Types

CMOS 4-Bit Arithmetic Logic Unit

High-Voltage Types (20-Volt Rating)

The RCA-CD40181B is a low-power four-bit parallel arithmetic logic unit (ALU) capable of providing 16 binary arithmetic operations on two four-bit words and 16 logical functions of two Boolean variables. The mode control input M selects logical (M = High) or arithmetic (M = Low) operation. The four select inputs (S0, S1, S2, and S3) select the desired logical or arithmetic functions, which include AND, OR, NAND, NOR, and exclusive-OR and NOR in the logic mode, and addition, subtraction, decrement, left-shift and straight transfer in the arithmetic mode, according to the truth table. The CD40181B operation may be interpreted with either active-low or active-high data at the A and B word inputs and the function outputs F, by using the appropriate truth table.

The CD40181B contains logic for full look-ahead carry operation for fast carry generation using the carry-generate and carry-propagate outputs \bar{G} and \bar{P} for the four bits of the CD40181B. Use of the CD40182B look-ahead carry generator in conjunction with multiple CD40181B's permits high-speed arithmetic operations on long words. A ripple carry output C_{n+4} is available for use in systems where speed is not of primary importance.

Also included in the CD40181B is a comparator output A = B, which assumes a high level whenever the two four-bit input words A and B are equal and the device is in the subtract mode. In addition, relative magnitude information may be derived from the carry-in input C_n and ripple carry-out output C_{n+4} by placing the unit in the subtract mode and externally decoding using the information in Table III.

The CD40181B types are supplied in 24-lead hermetic ceramic dual-in-line packages (D and F suffixes), 24-lead dual-in-line plastic packages (E suffix), 24-lead ceramic flat packages (K suffix), and in chip form (H suffix).

The CD40181 is similar to industry types MC14581 and 74181.

RECOMMENDED OPERATING CONDITIONS

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

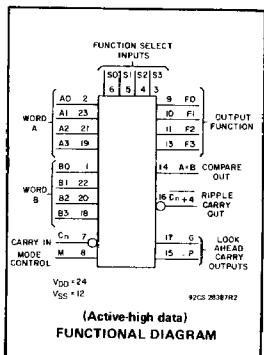
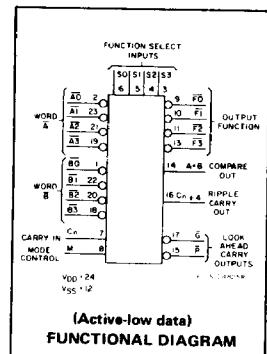
CHARACTERISTIC	LIMITS		UNITS
	Min.	Max.	
Supply-Voltage Range (For T_A = Full Package-Temperature Range)	3	18	V

Features:

- Full look-ahead carry for speed operations on long words
- Generates 16 logic functions of two Boolean variables
- Generates 16 arithmetic functions of two 4-bit binary words
- A = B comparator output available
- Ripple-carry input and output available
- Typical addition time 200 ns @ $V_{DD} = 10$ V
- Standardized, symmetrical output characteristics
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 μ A at 18 V over full package temperature range; 100 nA at 18 V and 25°C
- Noise margin (full package temperature range)
 - = 1 V at $V_{DD} = 5$ V
 - = 2 V at $V_{DD} = 10$ V
 - = 2.5 V at $V_{DD} = 15$ V
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13A, "Standard Specifications for Description of 'B' Series CMOS Devices"

Applications:

- Parallel arithmetic units
- Process controllers
- Low-power minicomputers



MAXIMUM RATINGS, Absolute-Maximum Values:

DC SUPPLY-VOLTAGE RANGE, (V_{DD})	-0.5 to +20 V
(Voltages referenced to V_{SS} Terminal)	
INPUT VOLTAGE RANGE, ALL INPUTS	-0.5 to V_{DD} + 0.5 V
DC INPUT CURRENT, ANY ONE INPUT	± 10 mA
POWER DISSIPATION PER PACKAGE (P_D):	
For $T_A = -40$ to $+60^\circ\text{C}$ (PACKAGE TYPE E)	500 mW
For $T_A = +60$ to $+85^\circ\text{C}$ (PACKAGE TYPE E)	Derate Linearly at 12 mW/ $^\circ\text{C}$ to 200 mW
For $T_A = -55$ to $+100^\circ\text{C}$ (PACKAGE TYPES D, F, K)	500 mW
For $T_A = +100$ to $+125^\circ\text{C}$ (PACKAGE TYPES D, F, K)	Derate Linearly at 12 mW/ $^\circ\text{C}$ to 200 mW
DEVICE DISSIPATION PER OUTPUT TRANSISTOR:	
For T_A = FULL PACKAGE-TEMPERATURE RANGE (All Package Types)	100 mW
OPERATING-TEMPERATURE RANGE (T_A):	
PACKAGE TYPES D, F, K, H	-55 to $+125^\circ\text{C}$
PACKAGE TYPE E	-40 to $+85^\circ\text{C}$
STORAGE TEMPERATURE RANGE (T_{STG})	-65 to $+150^\circ\text{C}$
LEAD TEMPERATURE (DURING SOLDERING):	
At distance $1/16 \pm 1/32$ inch (1.59 \pm 0.79 mm) from case for 10 s max.	+265°C

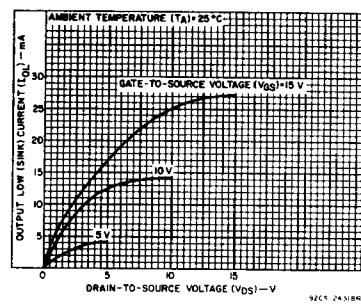


Fig. 1 — Typical output low (sink) current characteristics.

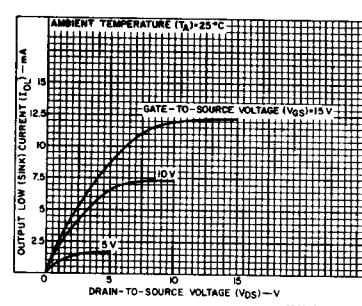


Fig. 2 — Minimum output low (sink) current characteristics.

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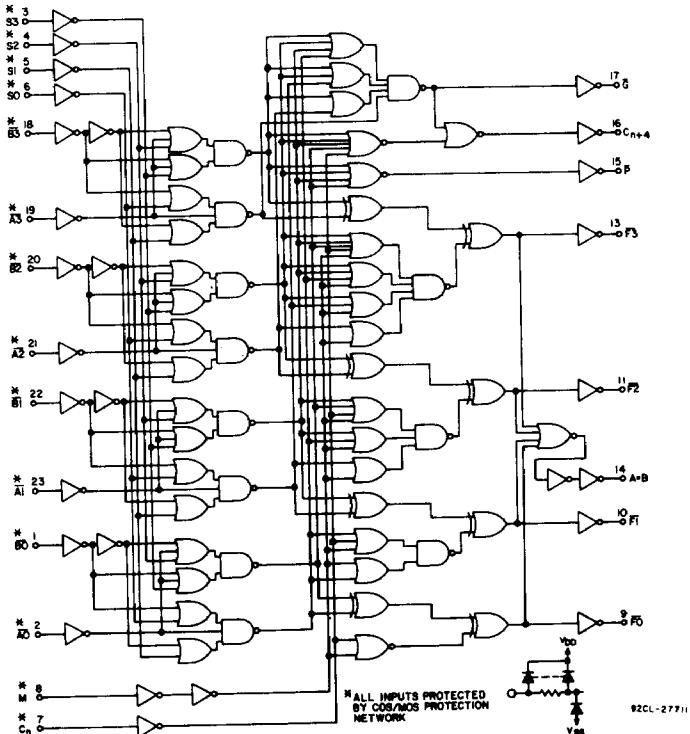


Fig. 3 – CD40181B logic diagram (active-low data).

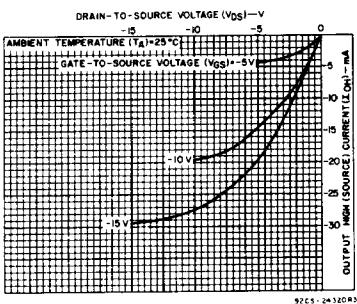


Fig. 4 – Typical output high (source) current characteristics.

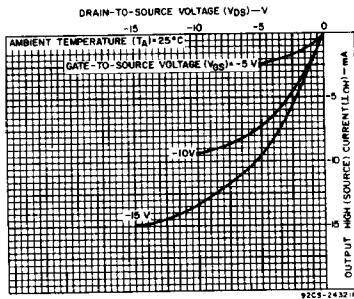


Fig. 5 – Minimum output high (source) current characteristics.

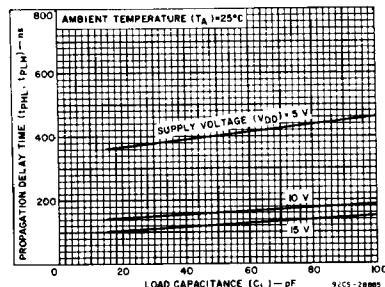


Fig. 6 – Typical propagation delay time as a function of load capacitance (for A or B to F, logic mode).

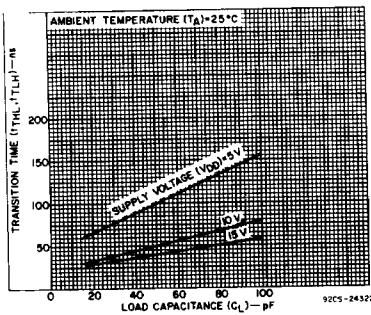


Fig. 7 – Typical transition time as a function of load capacitance.

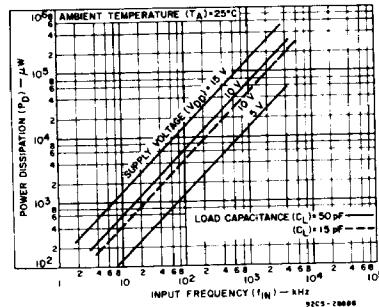


Fig. 8 – Typical dynamic dissipation as a function of input frequency (see Fig. 11 – dynamic power dissipation test circuit).

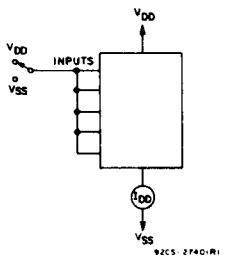


Fig. 9 – Quiescent-device-current test circuit.

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STATIC ELECTRICAL CHARACTERISTICS

CHARACTERISTIC	CONDITIONS			LIMITS AT INDICATED TEMPERATURES (°C)								UNITS
				Values at -55, +25, +125 Apply to D, F, K, H, Packages				Values at -40, +25, +85 Apply to E Package				
				V _O (V)	V _{IN} (V)	V _{DD} (V)	+25				UNITS	
Quiescent Device Current, I _{DD} Max.	-	0.5	5	5	5	150	150	-	0.04	5		
	-	0.10	10	10	10	300	300	-	0.04	10		
	-	0.15	15	20	20	600	600	-	0.04	20		
	-	0.20	20	100	100	3000	3000	-	0.08	100		
Output Low (Sink) Current, I _{OL} Min.	0.4	0.5	5	0.64	0.61	0.42	0.36	0.51	1	-	mA	
	0.5	0.10	10	1.6	1.5	1.1	0.9	1.3	2.6	-		
	1.5	0.15	15	4.2	4	2.8	2.4	3.4	6.8	-		
Output High (Source) Current, I _{OH} Min.	4.6	0.5	5	-0.64	-0.61	-0.42	-0.36	-0.51	-1	-		
	2.5	0.5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2	-		
	9.5	0.10	10	-1.6	-1.5	-1.1	-0.9	-1.3	-2.6	-		
	13.5	0.15	15	-4.2	-4	-2.8	-2.4	-3.4	-6.8	-		
Output Voltage: Low-Level, V _{OL} Max.	-	0.5	5	0.05	-	-	-	0	0.05	V		
	-	0.10	10	0.05	-	-	-	0	0.05			
	-	0.15	15	0.05	-	-	-	0	0.05			
Output Voltage: High-Level, V _{OH} Min.	-	0.5	5	4.95	-	4.95	5	-	-			
	-	0.10	10	9.95	-	9.95	10	-	-			
	-	0.15	15	14.95	-	14.95	15	-	-			
Input Low Voltage, V _{IL} Max.	0.5, 4.5	-	5	1.5	-	-	-	1.5	V			
	1.9	-	10	3	-	-	-	3				
	1.5, 13.5	-	15	4	-	-	-	4				
Input High Voltage, V _{IH} Min.	0.5, 4.5	-	5	3.5	-	3.5	-	-				
	1.9	-	10	7	-	7	-	-				
	1.5, 13.5	-	15	11	-	11	-	-				
Input Current I _{IN} Max.	-	0.18	18	±0.1	±0.1	±1	±1	-	±10 ⁻⁵	±0.1	μA	

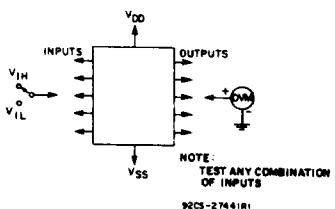


Fig. 10 – Input-voltage test circuit.

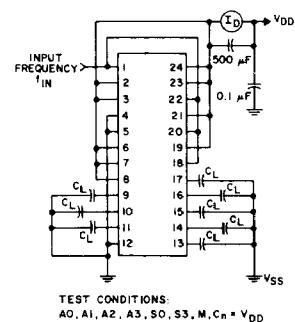


Fig. 11 – Dynamic power dissipation test circuit.

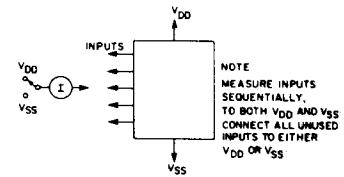
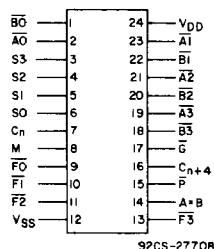


Fig. 12 – Input current test circuit.



Top View
Terminal Assignment
(Active-low Data)

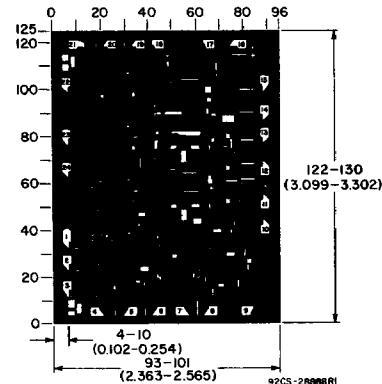
DYNAMIC ELECTRICAL CHARACTERISTICS at T_A = 25°C; Input t_r, t_f = 20 ns,
C_L = 50 pF, R_L = 200 kΩ

CHARACTERISTIC	V _{DD} (V)	LIMITS		UNITS
		Typ.	Max.	
Propagation Delay Time: t _{PHL} , t _{PLH} A or B to F (logic mode), A or B to G or P,	5	400	800	
	10	160	320	ns
	15	120	240	
A or B to F, C _n +4, or A = B,	5	500	1000	
	10	200	400	ns
	15	140	280	
C _n to F	5	320	640	
	10	135	270	ns
	15	100	200	
C _n to C _n +4	5	200	400	
	10	100	200	ns
	15	70	140	
Transition Time: t _{THL} , t _{TTLH}	5	100	200	
	10	50	100	ns
	15	40	80	
Input Capacitance, C _{IN} (Any Input)	-	5	7.5	pF

CD40181B Types

TABLE I
TRUTH TABLE

FUNCTION SELECT				LOGIC FUNCTION $M = H$	INPUTS/OUTPUT ACTIVE LOW	
S3	S2	S1	S0		ARITHMETIC* FUNCTION $M = L$	
					$C_n = L$	$C_n = H$
0	0	0	0	\bar{A}	A minus 1	A
0	0	0	1	\bar{AB}	AB minus 1	\bar{AB}
0	0	1	0	$\bar{A} + B$	\bar{AB} minus 1	$\bar{A}\bar{B}$
0	0	1	1	Logic 1	minus 1	Zero
0	1	0	0	$\bar{A} + \bar{B}$	$A + (A + \bar{B})$	$A + (A + \bar{B})$ plus 1
0	1	0	1	\bar{B}	AB plus $(A + \bar{B})$	AB plus $(A + \bar{B})$ plus 1
0	1	1	0	$A \oplus B$	A minus B minus 1	A minus B
0	1	1	1	$A + \bar{B}$	$A + \bar{B}$	$(A + \bar{B})$ plus 1
1	0	0	0	AB	A plus $(A + B)$	A plus $(A + B)$ plus 1
1	0	0	1	$A \oplus B$	A plus B	A plus B plus 1
1	0	1	0	B	\bar{AB} plus $(A + B)$	\bar{AB} plus $(A + B)$ plus 1
1	0	1	1	$A + B$	$A + B$	$A + B$ plus 1
1	1	0	0	Logic 0	A plus A	A plus A plus 1
1	1	0	1	$\bar{A}B$	AB plus A	AB plus A plus 1
1	1	1	0	AB	AB plus A	AB plus A plus 1
1	1	1	1	A	A	A plus 1



Dimensions and pad layout for CD40181BH.

FUNCTION SELECT				LOGIC FUNCTION $M = H$	INPUTS/OUTPUTS ACTIVE HIGH	
S3	S2	S1	S0		ARITHMETIC* FUNCTION $M = L$	
					$C_n = H$	$C_n = L$
0	0	0	0	\bar{A}	A	A plus 1
0	0	0	1	$A + B$	$A + B$	$(A + B)$ plus 1
0	0	1	0	\bar{AB}	$A + \bar{B}$	$(A + \bar{B})$ plus 1
0	0	1	1	Logic 0	minus 1	Zero
0	1	0	0	$\bar{A}B$	$A + \bar{A}B$	$A + \bar{A}B$ plus 1
0	1	0	1	B	$(A + B)$ plus $\bar{A}B$	$(A + B)$ plus $\bar{A}B$ plus 1
0	1	1	0	$A \oplus B$	A minus B minus 1	A minus B
0	1	1	1	$\bar{A}B$	$\bar{A}B$ minus 1	$\bar{A}B$
1	0	0	0	$\bar{A} + B$	A plus AB	A plus AB plus 1
1	0	0	1	$A \oplus B$	A plus B	A plus B plus 1
1	0	1	0	B	$(A + \bar{B})$ plus AB	$(A + \bar{B})$ plus AB plus 1
1	0	1	1	AB	AB minus 1	AB
1	1	0	0	Logic 1	A plus A	A plus A plus 1
1	1	0	1	$A + \bar{B}$	$(A + B)$ plus A	$(A + B)$ plus A plus 1
1	1	1	0	$A + B$	$(A + \bar{B})$ plus A	$(A + \bar{B})$ plus A plus 1
1	1	1	1	A	A minus 1	A

* Expressed as two's complement.

1 = HIGH LEVEL

0 = LOW LEVEL

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10^{-3} inch).

The photographs and dimensions of each CMOS chip represent a chip when it is part of the wafer. When the wafer is separated into individual chips, the angle of cleavage may vary with respect to the chip face for different chips. The actual dimensions of the isolated chip, therefore, may differ slightly from the nominal dimensions shown. The user should consider a tolerance of -3 mils to +16 mils applicable to the nominal dimensions shown.

CD40181B Types

TABLE II
AC TEST SETUP REFERENCE (ACTIVE-LOW DATA)

TEST DELAY TIMES	AC PATHS		DC DATA INPUTS		MODE*
	INPUTS	OUTPUTS	TO V _{SS}	TO V _{DD}	
SUM _{IN} to SUM _{OUT}	\bar{B}_0	Any \bar{F}	$\bar{B}_1, \bar{B}_2, \bar{B}_3,$ M, C_n	All \bar{A} 's	ADD
SUM _{IN} to \bar{P}	\bar{A}_0	\bar{P}	$\bar{A}_1, \bar{A}_2, \bar{A}_3,$ M, C_n	All \bar{B} 's	ADD
SUM _{IN} to \bar{G}	\bar{B}_0	\bar{G}	All \bar{A} 's M, C_n	$\bar{B}_1, \bar{B}_2, \bar{B}_3$	ADD
SUM _{IN} to C_{n+4}	\bar{B}_0	C_{n+4}	All \bar{A} 's, M, C_n	$\bar{B}_1, \bar{B}_2, \bar{B}_3$	ADD
C_n to SUM _{OUT}	C_n	Any \bar{F}	All \bar{A} 's, M	All \bar{B} 's	ADD
C_n to C_{n+4}	C_n	C_{n+4}	All \bar{A} 's, M	All \bar{B} 's	ADD
SUM _{IN} to A = B	\bar{B}_0	A = B	All A's, $B_1, B_2, B_3,$ M	C_n	SUBTRACT
SUM _{IN} to SUM _{OUT} (Logic Mode)	All \bar{B} 's	Any \bar{F}	All \bar{A} 's, C_n	M	EXCLUSIVE OR

* ADD Mode: SO, S3 = V_{DD}; S1, S2 = V_{SS}.

SUBTRACT Mode: SO, S3 = V_{SS}; S1, S2 = V_{DD}.

TABLE III
MAGNITUDE COMPARISON

ACTIVE - HIGH DATA			ACTIVE - LOW DATA		
INPUT C_n	OUTPUT C_{n+4}	MAGNITUDE	INPUT C_n	OUTPUT C_{n+4}	MAGNITUDE
1	1	$A \leq B$		0	$A \leq B$
0	1	$A < B$		1	$A < B$
1	0	$A > B$		0	$A > B$
0	0	$A \geq B$		1	$A \geq B$

1 = HIGH LEVEL

0 = LOW LEVEL